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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	AA	2,567,016	09/04/1951	Gessler et al.			
	AB	3,149,178	09/15/1964	Hamilton et al.			
	AC	3,201,364	08/17/1965	Salyer			
	AD	3,228,896	01/11/1966	Canterino			
	AE	3,235,529	02/15/1966	Nagle			
	AF	3,239,478	03/08/1966	Harlan, Jr.			
	AG	3,281,390	10/25/1966	O'Leary, Jr.			
	AH	3,299,568	01/24/1967	Tobolsky			
	AI	3,308,086	03/07/1967	Wartman			
	AJ	3,318,835	05/09/1967	Hagemeyer, Jr. et al.			
	AK	3,338,778	08/29/1967	Hutchins et al.			
	AL	3,361,702	01/02/1968	Wartman et al.			
	AM	3,415,925	12/10/1968	Marans			
	AN	3,437,627	04/08/1969	Gude et al.			
	AO	3,439,088	04/15/1969	Edman			
	AP	3,464,949	09/02/1969	Wartman et al.			
	AQ	3,475,368	10/28/1969	Metz			
	AR	3,536,796	10/27/1970	Rock			
	AS	3,541,039	11/17/1970	Whiton			
	AT	3,563,934	02/16/1971	Burnett			
	AU	3,752,779	08/14/1973	Maciejewski			
	AV	3,818,105	06/18/1974	Coopersmith et al.			
	AW	3,821,148	06/28/1974	Makowski et al.			
	AX	3,839,261	10/01/1974	Aronoff et al.			
	AY	3,860,543	01/14/1975	Masuda et al.			
	AZ	3,925,504	12/09/1975	Koleske et al.			
	BA	3,925,947	12/16/1975	Meyers et al.			
NN	BB	3,945,975	03/23/1976	Strack			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	BC	3,988,276	10/26/1976	Kutch et al.			
	BD	4,006,115	02/01/1977	Elbert			
	BE	4,010,127	03/01/1977	Taka et al.			
	BF	4,061,805	12/06/1977	Thompson et al.			
	BG	4,063,002	12/13/1977	Wilson, Jr.			
	BH	4,073,782	02/14/1978	Kishi et al.			
	BI	4,092,282	05/30/1978	Callan			
	BJ	4,094,850	06/13/1978	Morgan et al.			
	BK	4,104,216	08/01/1978	Clampitt			
	BL	4,110,185	08/29/1978	Williams et al.			
	BM	4,118,359	10/03/1978	Brenner			
	BN	4,118,362	10/03/1978	Makowski et al.			
	BO	4,131,587	12/26/1978	Brenner			
	BP	4,132,698	01/02/1979	Gessler et al.			
	BQ	4,136,072	01/23/1979	Ladish et al.			
	BR	4,138,378	02/06/1979	Doss			
	BT	4,147,831	04/03/1979	Balint			
	BU	4,153,582	05/08/1979	Puffr et al.			
	BV	4,153,588	05/08/1979	Makowski et al.			
	BW	4,153,594	05/08/1979	Wilson, Jr.			
	BX	4,154,712	05/15/1979	Lee, Jr.			
	BY	4,154,244	05/15/1979	Becker et al.			
	CA	4,157,992	06/12/1979	Lundberg et al.			
	CB	4,166,057	08/28/1979	Takemori			
	CC	4,169,822	10/02/1979	Kutch et al.			
	CD	4,170,586	10/09/1979	Clampitt et al.			
	CE	4,175,069	11/20/1979	Brenner			
NN	CF	4,189,411	02/19/1980	Haaf			
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*EXAMINER INITIALS	CLASS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	CG	4,210,570	07/01/1980	Trotter et al.			
	CH	4,221,887	09/09/1980	Brenner et al.			
	CI	4,229,337	10/21/1980	Brenner			
	CJ	4,237,083	12/02/1980	Young et al.			
	CK	4,274,932	06/23/1981	Williams et al.			
	CL	4,288,358	09/08/1981	Trotter et al.			
	CM	4,288,480	09/08/1981	Grzywinski et al.			
	CO	4,289,668	09/15/1981	Li			
	CP	4,311,628	01/19/1982	Abdou-Sabet et al.			
	CQ	4,322,336	03/30/1982	Machurat et al.			
	CS	4,325,850	04/20/1982	Mueller			
	CT	4,327,007	04/27/1982	Vanderkooi, Jr. et al.			
	CU	4,335,026	06/15/1982	Balint			
	CV	4,335,034	06/15/1982	Zuckerman et al.			
	CW	4,340,513	07/20/1982	Moteki et al.			
	CX	4,347,332	08/31/1982	Odorzynski et al.			
	CY	4,352,823	10/05/1982	Cherukuri et al.			
	CZ	4,369,284	01/18/1983	Chen			
	DA	4,379,169	04/05/1983	Reggio et al.			
	DB	4,387,108	06/07/1983	Koch et al.			
	DC	4,399,248	08/16/1983	Singh et al.			
	DD	4,399,251	08/16/1983	Lee			
	DE	4,403,005	09/06/1983	Nevins et al.			
	DF	4,403,007	09/06/1983	Coughlin			
	DG	4,409,345	10/11/1983	Moteki et al.			
	DH	4,434,258	02/28/1984	Schumacher et al.			
	DI	4,438,228	03/20/1984	Schenck			
NN	DJ	4,438,229	03/20/1984	Fujimori et al.			

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NN	DK	4,440,829	04/03/1984	Gerace et al.			
	DL	4,450,250	05/22/1984	McConnell et al.			
	DM	4,452,820	06/05/1984	D'Amelia et al.			
	DN	4,459,311	07/10/1984	DeTora et al.			
	DO	4,460,729	07/17/1984	Books			
	DP	4,467,065	08/21/1984	Williams et al.			
	DQ	4,469,770	09/04/1984	Nelson			
	DR	4,497,926	02/05/1985	Toy			
	DS	4,504,604	03/12/1985	Pilkington et al.			
	DT	4,518,615	05/21/1985	Cherukuri et al.			
	DU	4,529,666	07/16/1985	Salzburg et al.			
	DV	4,532,305	07/30/1985	Dickinson			
	DW	4,536,537	08/20/1985	Klingensmith et al.			
	DX	4,542,053	09/17/1985	Nevins et al.			
	DY	4,551,507	11/05/1985	Haylock et al.			
	DZ	4,552,801	11/12/1985	Odorzynski et al.			
	EA	4,579,901	04/01/1986	Allen et al.			
	EB	4,584,215	04/22/1986	Bré et al.			
	EC	4,616,052	10/07/1986	Habibullah			
	ED	4,645,791	02/24/1987	Theodore et al.			
	EE	4,659,757	04/21/1987	Okamoto et al.			
	EF	4,663,220	05/05/1987	Wisneski et al.			
	EG	4,666,959	05/19/1987	Weissberger et al.			
	EH	4,666,968	05/19/1987	Downey et al.			
	EI	4,670,341	06/02/1987	Lundsager			
	EJ	4,684,682	08/04/1987	Lee, Jr.			
	EK	4,703,078	10/27/1987	Machara et al.			
NN	EL	4,749,734	06/07/1988	Williams et al.			
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NN	EM	4,745,143	05/17/1988	Mason et al.			
	EN	4,746,388	05/24/1988	Inaba et al.			
	EO	4,764,535	08/16/1988	Leicht			
	EP	4,772,657	09/20/1988	Akiyama et al.			
	EQ	4,774,277	09/27/1988	Janac et al.			
	ER	4,814,375	03/21/1989	Esposito			
	ES	4,824,891	04/25/1989	Laurent et al.			
	ET	4,833,172	05/23/1989	Schwarz et al.			
	EU	4,833,195	05/23/1989	Adur et al.			
	EV	4,840,988	06/20/1989	Nakayama et al.			
	EW	4,845,137	07/04/1989	Williams et al.			
	EX	4,914,145	04/03/1990	Tohdoh et al.			
	EY	4,919,992	04/24/1990	Blundell et al.			
	EZ	4,939,040	07/03/1990	Oreglia et al.			
	FA	4,952,457	08/28/1990	Cartier et al.			
	FB	4,957,958	09/18/1990	Schleifstein			
	FC	4,959,285	09/25/1990	Hoffmann			
	FD	4,959,396	09/25/1990	Yankov et al.			
	FE	4,959,402	09/25/1990	Williams et al.			
	FF	4,960,820	10/02/1990	Hwo			
	FG	4,995,884	02/26/1991	Ross et al.			
	FH	4,996,094	02/26/1991	Dutt			
	FI	5,026,756	06/25/1991	Arendt			
	FJ	5,028,647	07/02/1991	Haylock et al.			
	FK	5,080,942	01/14/1992	Yau			
	FL	5,091,454	02/25/1992	Arendt			
	FM	5,093,197	03/03/1992	Howard et al.			
NN	FN	5,106,899	04/21/1992	Maresca			

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NN	FO	5,116,626	05/26/1992	Synosky et al.			
	FP	5,124,384	06/23/1992	Goldstein			
	FQ	5,149,736	09/22/1992	Gamarra			
	FR	5,171,908	12/15/1992	Rudnick			
	FS	5,173,317	12/22/1992	Hartman et al.			
	FT	5,206,276	04/27/1993	Lee, Jr.			
	FU	5,230,843	07/27/1993	Howard et al.			
	FV	5,231,128	07/27/1993	Nakata et al.			
	FW	5,238,735	08/24/1993	Nagou et al.			
	FX	5,250,628	10/05/1993	Seguela et al.			
	FY	5,256,717	10/26/1993	Stauffer et al.			
	FZ	5,258,419	11/02/1993	Rolando et al.			
	GA	5,264,474	11/23/1993	Schleifstein et al.			
	GB	5,278,220	01/11/1994	Vermeire et al.			
	GC	5,286,500	02/15/1994	Synosky et al.			
	GD	5,290,886	03/01/1994	Ellul			
	GE	5,308,904	05/03/1994	Fujii et al.			
	GF	5,312,856	05/17/1994	Hert et al.			
	GG	5,324,580	06/28/1994	Allan et al.			
	GH	5,356,709	10/18/1994	Woo et al.			
	GI	5,356,948	10/18/1994	Payne, Jr. et al.			
	GJ	5,356,986	10/18/1994	Stewart et al.			
	GK	5,376,716	12/27/1994	Nayak et al.			
	GL	5,389,711	02/14/1995	Westbrook et al.			
	GM	5,397,832	03/14/1995	Elul			
	GN	5,409,041	04/25/1995	Yoshida et al.			
	GO	5,424,080	06/13/1995	Synosky et al.			
NN	GP	5,437,877	08/01/1995	Synosky et al.			

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	GQ	5,442,004	08/15/1995	Sutherland et al.			
	GR	5,459,193	10/17/1995	Anderson et al.			
	GS	5,462,754	10/31/1995	Synosky et al.			
	GT	5,462,981	10/31/1995	Bastoli et al.			
	GU	5,489,646	02/06/1996	Tatman et al.			
	GV	5,492,943	02/20/1996	Stempel			
	GW	5,512,625	04/30/1996	Butterbach et al.			
	GX	5,563,222	10/08/1996	Fukuda et al.			
	GY	5,601,858	02/11/1997	Mansukhani et al.			
	GZ	5,624,986	04/29/1997	Bunnelle et al.			
	HA	5,663,230	09/02/1997	Haman			
	HB	5,683,634	11/04/1997	Fujii et al.			
	HC	5,683,815	11/04/1997	Leiss			
	HD	5,688,850	11/18/1997	Wyffels			
	HE	5,726,239	03/10/1998	Maes et al.			
	HF	5,728,760	03/17/1998	Rose et al.			
	HG	5,736,197	04/07/1998	Gaveske			
	HH	5,739,200	04/14/1998	Cheung et al.			
	HI	5,741,840	04/21/1998	Lindquist et al.			
	HJ	5,747,573	05/05/1998	Ryan			
	HK	5,786,418	07/28/1998	Strelow et al.			
	HL	5,789,529	08/04/1998	Matsumura et al.			
	HM	5,804,630	09/08/1998	Heyer et al.			
	HN	5,837,769	11/17/1998	Graafland et al.			
	HO	5,849,806	12/15/1998	St. Clair et al.			
	HP	5,869,555	02/09/1999	Simmons et al.			
	HQ	5,869,560	02/09/1999	Kobayashi et al.			
NN	HR	5,869,562	02/09/1999	Lindquist et al.			

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	HS	5,872,183	02/16/1999	Bonnet et al.			
	HT	5,908,412	06/01/1999	Beger			
	HU	5,916,959	06/29/1999	Lindquist et al.			
	HV	5,929,147	07/27/1999	Pierick et al.			
	HW	5,939,483	08/17/1999	Kueppers			
	HX	5,948,557	09/07/1999	Ondeck et al.			
	HY	6,001,455	12/14/1999	Nishio et al.			
	HZ	6,017,986	01/25/2000	Burton			
	IA	6,027,674	02/22/2000	Yates			
	IB	6,045,922	04/04/2000	Jannssen et al.			
	IC	6,060,561	09/09/2000	Wolfshwenger et al.			
	ID	6,077,899	06/20/2000	Yatsuyanagi et al.			
	IE	6,084,031	07/04/2000	Medsker et al.			
	IF	6,086,996	07/11/2000	Rancich et al.			
	IG	6,127,444	10/03/2000	Kadri			
	IH	6,143,818	11/07/2000	Huang et al.			
	II	6,190,769	02/20/2001	Wang			
	IJ	6,194,498	02/27/2001	Anderson et al.			
	IK	6,231,936	05/15/2001	Kozimor et al.			
	IL	6,231,970	05/15/2001	Anderson et al.			
	IM	6,271,294	08/07/2001	Lasson et al.			
	IN	6,316,068	11/13/2001	Masubuchi et al.			
	IO	6,326,426	12/04/2001	Ellul			
	IP	6,329,468	12/11/2001	Wang			
	IQ	6,337,364	01/08/2002	Sakaki et al.			
	IR	6,342,209	01/29/2002	Patil et al.			
	IS	6,342,320	01/29/2002	Liu et al.			
NN	IT	6,342,565	01/29/2002	Cheng et al.			
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NN	IU	6,348,563	02/19/2002	Fukuda et al.			
	IV	6,362,252	03/26/2002	Prutkin			
	IW	6,372,379	04/16/2002	Samii et al.			
	IX	6,380,292	04/30/2002	Gibes et al.			
	IY	6,384,115	05/07/2002	Van Gysel et al.			
	IZ	6,410,200	06/25/2002	Williams et al.			
	JA	6,413,458	07/02/2002	Pearce			
	JB	6,448,338	09/10/2002	Born et al.			
	JC	6,451,915	09/17/2002	Ellul et al.			
	JD	6,465,109	10/15/2002	Ohtsuka			
	JE	6,482,281	11/19/2002	Schmidt			
	JF	6,509,128	01/21/2003	Everaerts et al.			
	JG	6,531,214	03/11/2003	Carter et al.			
	JH	6,538,066	03/25/2003	Watanabe et al.			
	JI	6,559,232	05/06/2003	Inoue et al.			
	JJ	6,583,207	06/24/2003	Stanhope et al.			
	JK	6,610,768	08/26/2003	Jelenic et al.			
	JL	6,623,847	09/23/2003	Yates			
	JM	6,639,020	10/28/2003	Brant			
	JN	6,730,739	05/04/2004	Gipson			
	JO	6,867,253	03/15/2005	Chen			
	JP	2001/0051265	12/13/2001	Williams et al.			
	JQ	2002/0049276	04/25/2002	Zwick			
	JR	2002/0077409	06/20/2002	Sakaki et al.			
	JS	2002/0147266	10/10/2002	Rawlinson et al.			
	JT	2002/0155267	10/24/2002	Bader			
	JU	2002/0160137	10/31/2002	Varma			
NN	JV	2002/0168518	11/14/2002	Bond et al.			
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NN	JW	2003/0004266	01/02/2003	Kitazaki et al.			
	JX	2003/0181584	09/25/2003	Handlin, Jr. et al.			
	JY	2003/0032696	02/13/2003	Sime et al.			
	JZ	2003/0091803	05/15/2003	Bond et al.			
	KA	2003/0092826	05/15/2003	Pearce			
	KB	2003/0134552	07/17/2003	Mehawej et al.			
	KC	2003/035951	02/20/2003	Magill et al.			
	KD	2003/0187081	10/02/2003	Cui			
	KE	2003/157859	08/21/2003	Ishikawa			
	KF	2004/214498	10/28/2004	Webb et al.			
	KG	2004/0034148	02/19/2004	Kelly et al.			
	KH	2004/0070653	04/15/2004	Mashita et al.			
	KI	2004/106723	06/03/2004	Yang et al.			
	KJ	2004/186214	09/23/2004	Li et al.			
NN	KK	2004/260001	12/23/2004	Lin et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBL. DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
NN	KL	CS 215313	08/27/1982	Serbia-Montenegro w/ abstract				X
	KM	DE 1 282 942	11/14/1968	Germany w/Abstract				X
	KN	DE 1 669 261	10/29/1970	Germany w/Abstract				X
	KO	DE 1 921 649	11/19/1970	Germany w/Abstract				X
	KP	DE 1 961 981	07/09/1970	Germany w/Abstract				X
	KQ	DE 198 41 303	03/23/2000	Germany w/Abstract				X
	KR	DE 2 019 945	11/04/1971	Germany w/Abstract				X
	KS	DE 2 108 293	08/31/1972	Germany w/Abstract				X
	KT	DE 26 32 957	01/26/1978	Germany w/Abstract				X
	KU	DE 32 44 499	06/16/1983	Germany w/Abstract				X
	KV	DE 37 35 502	05/03/1989	Germany w/Abstract				X
NN	KW	DE 39 11 725	10/18/1990	Germany w/Abstract				X

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*EXAMINER INITIAL		DOCUMENT NUMBER	PUBL DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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NN	KX	DE 44 17 191	08/31/1995	Germany w/Abstract				X
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	KZ	EP 0 046 536	01/23/1985	Europe				
	LA	EP 0 299 718	01/18/1989	Europe				
	LB	EP 0 214 112	03/11/1987	Europe				
	LC	EP 0 217 516	04/08/1987	Europe				
	LD	EP 0 255 735	02/10/1988	Europe				
	LE	EP 0 300 689	01/25/1989	Europe				
	LF	EP 0 315 363	10/26/1988	Europe				
	LG	EP 0 321 868	06/28/1989	Europe				
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	LJ	EP 0 369 164	05/23/1990	Europe				
	LK	EP 0 389 695	10/03/1990	Europe				
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	LM	EP 0 409 155	05/11/1994	Europe w/Abstract				X
	LO	EP 0 428 153	03/22/1995	Europe w/Abstract				X
	LP	EP 0 448 259	09/25/1991	Europe				
	LQ	EP 0 050 548	01/16/1985	Europe w/Abstract				X
	LR	EP 0 513 470	11/19/1992	Europe				
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	LT	EP 0 058 404	01/22/1986	Europe				
	LU	EP 0 087 294	08/31/1983	Europe				
	LV	EP 0 614 939	09/14/1994	Europe w/Abstract				X
	LW	EP 0 617 077	09/28/1994	Europe w/Abstract				X
	LX	EP 0 622 432	11/02/1994	Europe				
	LY	EP 0 664 315	07/26/1995	Europe				
	LZ	EP 0 677 548	10/18/1995	Europe w/Abstract				X
	MA	EP 0 073 042	10/07/1987	Europe				
	MB	EP 0 742 227	11/13/1996	Europe				
	MC	EP 0 083 049	07/06/1983	Europe				
NN	MD	EP 0 801 104	10/15/1997	Europe w/Abstract				X

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NN	ME	EP 0 940 433	09/08/1999	Europe				
	MF	EP 0 097 969	01/11/1984	Europe				
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	MH	EP 1 104 783	06/06/2001	Europe w/Abstract				X
	MI	EP 1 201 391	05/02/2002	Europe w/Abstract				X
	MJ	EP 1 211 285	06/05/2002	Europe				
	ML	EP 1 331 258	07/30/2003	Europe				
	MM	FR 1 167 244	11/21/1958	France w/Abstract				X
	MN	FR 1 536 425	07/08/1968	France w/Abstract				X
	MO	FR 1566388	03/31/1969	France w/Abstract				X
	MP	FR 1 580 539	09/05/1969	France				X
	MQ	FR 2094870	02/04/1972	France				X
	MR	FR 2 110 824	06/02/1972	France				X
	MS	FR 2.212.382	07/26/1974	France				X
	MT	FR 2 256 207	12/26/1974	France				X
	MU	FR 2 272 143	05/21/1975	France				X
	MV	FR 2 590 910	06/05/1987	France				X
	MW	FR 2 602 515	02/12/1988	France				X
	MX	GB 964 845	07/22/1964	Great Britain				
	MY	GB 1,044,028	09/28/1966	Great Britain				
	MZ	GB 1,044,502	10/05/1966	Great Britain				
	NA	GB 1,044,503	10/05/1966	Great Britain				
	NB	GB 1,166,664	10/08/1969	Great Britain				
	NC	GB 1,252,638	11/10/1971	Great Britain				
	ND	GB 1,329,915	09/12/1973	Great Britain				
	NE	GB 1 331988	09/26/1973	Great Britain				
	NF	GB 1,452,911	10/20/1976	Great Britain				
	NG	GB 1,458,915	12/15/1976	Great Britain				
	NH	GB 1,559,058	01/16/1980	Great Britain				
	NI	GB 2 180 790	04/08/1987	Great Britain				
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NN	NK	JP 11060789	03/05/1999	Japan w/Abstract				X
EXAMINER /Nathan Nutter/ (11/24/2006)				DATE CONSIDERED				
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				2/19/2004		1711	
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	PUBL DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
NN	NL	JP 11291422	10/26/1999	Japan w/Abstract			X
	NM	JP 01282280	11/14/1989	Japan w/Abstract			
	NN	JP 03037481	02/18/1991	Japan w/Abstract			X
	NO	JP 04063851	02/28/1992	Japan			
	NP	JP 07118492	05/09/1995	Japan w/Abstract			X
	NQ	JP 08269417	10/15/1996	Japan w/Abstract			X
	NR	JP 10036569	02/10/1998	Japan w/Abstract			X
	NS	JP 10279750	10/20/1998	Japan w/Abstract			X
	NT	JP 56045932	04/25/1981	Japan w/Abstract			X
	NU	JP 60112439	06/18/1985	Japan w/Abstract			X
	NV	JP 62132943	06/16/1987	Japan w/Abstract			X
	NW	JP 62223245	10/01/1987	Japan w/Abstract			X
	NX	JP 69029554	12/14/1966	Japan w/Abstract			
	NY	JP 88033788	02/13/1988	Japan w/Abstract			
	NZ	JP 95085907	03/31/1995	Japan w/Abstract			X
	OA	JP 7292167	11/07/1995	Japan w/Abstract			X
	OB	JP 9208761	08/12/1997	Japan w/Abstract			X
	OC	JP 56095938	08/03/1981	Japan w/Abstract			X
	OD	JP 5112842	05/07/1993	Japan w/Abstract			X
	OE	JP 2000154281	06/06/2000	Japan			X
	OF	JP 01106628	04/24/1989	Japan w/Abstract			X
	OG	JP 02/038114	02/07/1990	Japan w/Abstract			X
	OH	JP 07216143	08/15/1995	Japan w/Abstract			X
	OI	JP 53102381	09/06/1978	Japan w/Abstract			X
	OJ	JP 2001233992	08/20/2001	Japan w/Abstract			X
	OK	JP 01016638	01/20/1989	Japan w/Abstract			X
	OL	JP 11080455	03/26/1999	Japan w/Abstract			X
	OM	JP 11020397	01/26/1999	Japan w/Abstract			X
	ON	JP 09104801	04/22/1997	Japan w/Abstract			X
	OO	JP 07247387	09/26/1995	Japan w/Abstract			X
NN	OP	JP06345893	12/20/1994	Japan w/Abstract			X
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NN	OQ	JP 01066253	03/13/1989	Japan w/Abstract				X
	OR	JP 68013376	06/06/1943	Japan w/Abstract				X
	OS	JP 03269036	11/29/1991	Japan w/Abstract				X
	OT	JP 05098088	04/20/1993	Japan w/Abstract				X
	OU	JP 53023388	03/03/1978	Japan w/Abstract				X
	OV	JP 50123148	09/27/1975	Japan w/Abstract				X
	OW	JP 50151243	12/04/1975	Japan w/Abstract				X
	OX	JP 53060383	05/30/1978	Japan w/Abstract				X
	OY	JP 2067344	03/07/1990	Japan w/Abstract				X
	OZ	JP 96019286	01/19/1996	Japan w/Abstract				X
	PA	JP 96019287	02/28/1996	Japan w/Abstract				
	PB	JP 10324783	12/08/1998	Japan w/Abstract				X
	PC	JP 2001342355	12/14/2001	Japan w/Abstract				X
	PD	JP 07214685	08/15/1995	Japan w/Abstract				X
	PE	JP 2730079	03/25/1998	Japan w/Abstract				
	PF	JP 3325377	09/17/2002	Japan w/Abstract				
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	PH	JP 10017693	01/20/1998	Japan w/Abstract				X
	PI	JP 2001064523	03/13/2001	Japan w/Abstract				X
	PJ	JP 2001131509	05/15/2001	Japan w/Abstract				X
	PK	JP 2001279031	10/10/2001	Japan w/Abstract				X
	PL	JP 9087435	03/31/1997	Japan w/Abstract				X
	PM	JP 08333557	12/17/1996	Japan w/Abstract				X
	PN	JP 08034862	03/06/1996	Japan w/Abstract				X
	PO	JP 89017495	01/20/1989	Japan w/Abstract				X
	PP	JP 76029170	03/12/1976	Japan w/Abstract				X
	PQ	JP 44029554	12/06/1969	Japan w/Abstract				X
	PR	JP 63251436	10/18/1988	Japan w/Abstract				X
	PS	JP 04257361	09/11/1992	Japan w/Abstract				X
	PT	JP 08246232	09/24/1996	Japan w/Abstract				X
	PU	JP 10158971	06/16/1998	Japan w/Abstract				X
NN	PV	JP 10325060	12/08/1998	Japan w/Abstract				X

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EXAMINER INITIAL		DOCUMENT NUMBER	PUBL. DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
NN	PW	JP 11239587	09/07/1999	Japan w/Abstract				X
	PX	JP 2004345327	12/09/2004	Japan w/Abstract				
	PY	WO 80/00028	01/10/1980	PCT				
	PZ	WO 89/08681	09/21/1989	PCT w/Abstract				X
	QA	WO 92/16583	10/01/1992	PCT				
	QB	WO 94/15014	07/07/1994	PCT				
	QC	WO 95/13316	05/18/1995	PCT w/Abstract				X
	QD	WO 96/04419	02/15/1996	PCT				
	QE	WO 96/11231	04/18/1996	PCT w/Abstract				X
	QF	WO 96/11232	04/18/1996	PCT w/Abstract				X
	QG	WO 96/26242	08/29/1996	PCT				
	QH	WO 97/10298	03/20/1997	PCT				
	QI	WO 97/19582	06/05/1997	PCT				
	QJ	WO 97/33921	09/18/1997	PCT				
	QL	WO 98/36783	08/27/1998	PCT				
	QM	WO 98/44041	10/08/1998	PCT				
	QN	WO 98/46694	10/22/1998	PCT				
	QO	WO 99/13016	03/18/1999	PCT				
	QP	WO 99/62987	12/09/1999	PCT w/Abstract				X
	QQ	WO 00/66662	11/09/2000	PCT w/Abstract				X
	QR	WO 01/02263	01/11/2001	PCT				
	QS	WO 01/43963	06/21/2001	PCT				
	QT	WO 01/18109	03/15/2001	PCT				
	QU	WO 02/10310	02/07/2002	PCT w/Abstract				X
	QV	WO 02/17973	03/07/2002	PCT				
	QW	WO 02/30194	04/18/2002	PCT				
	QX	WO 02/062891	08/15/2002	PCT				
	QY	WO 02/072689	09/19/2002	PCT w/Abstract				X
	QZ	WO 02/074873	09/26/2002	PCT				
	RA	WO 02/18487	03/07/2002	PCT				
NN	RB	WO 02/31044	04/18/2002	PCT				

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FOREIGN PATENT DOCUMENTS

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NN	RC	WO 03/048252	06/12/2003	PCT				
	RD	WO 04/009699	01/29/2004	PCT				
	RQ	DE 32 44 499	06/16/83	Germany				X
	RR	DE 37 35 502	05/03/98	Germany				X
	RS	EP 0 614 939	09/14/94	Europe				
NN	RT	EP 0 664 315	07/26/95	Europe				

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	RE	4,132,698	01/02/79	Gessler et al.			
	RF	4,274,932	06/23/81	Williams et al.			
	RG	4,369,284	01/18/83	Chen			
	RH	4,460,729	07/17/84	Books			
	RI	4,467,065	08/21/84	Williams et al.			
	RJ	4,666,959	05/19/87	Weissberger et al.			
	RK	4,749,734	06/07/88	Williams et al.			
	RL	4,959,402	09/25/90	Williams et al.			
	RM	5,258,419	11/02/93	Rolando et al.			
	RN	5,356,709	10/18/94	Woo et al.			
	RO	5,356,948	10/18/94	Payne, Jr. et al.			
NN	RP	5,376,716	12/27/94	Nayak et al.			

FOREIGN PATENT DOCUMENTS

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NN	RW	WO 02/088238	11/07/2002	PCT w/Abstract				X
	RX	WO 02/18487	03/07/2002	PCT				
	RY	WO 02/31044	04/18/2002	PCT				
	RZ	WO 03/029379	04/10/2003	PCT w/Abstract				X
NN	SA	WO 03/048252	06/12/2003	PCT				

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		Wen LI et al.			
		FILING DATE		GROUP	
		2/19/2004		1711	

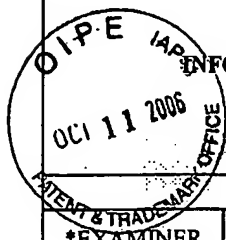
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	SC	03/066729	08/14/2003	PCT w/Abstract				X
	SD	04/014997	02/19/2004	PCT				
	SE	04/20195	03/11/2004	PCT				
NN	SF	04/31292	09/26/2003	PCT				

OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages of Publication, Etc.)		
NN	SG	Abstract of JP 8253754, published on 10/01/96, entitled, "Method for Foaming Reactive Hot-Melt Polyurethane Adhesive"
	SH	PCT Written Opinion, 01/07/04, 2002B107B
	SI	"Swelling Interaction, Plasticization, and Antioxidant extraction Between Fiber Optic Cable Gels and Polyolefins" B. G. Risch, Ph.D., SPE-ANTEC, 1999
	SJ	"Use of "Clean" Paraffinic Processing Oils to Improve TPE Properties", B. J. Gedeon et al., TPEs, 2000, pp. 157-170
	SK	"Plasticizing of isotactic polypropylene upon addition of hydrocarbon oils", K. Nitta et al., e-Polymers, no. 021, 2004, pp. 1 - 11
	SL	"The Effect of Oil Type and Content on the Rheological, Mechanical and Thermal Properties of a Polyolefinic Based Thermoplastic Elastomer", McShane, et al. SPE-ANTEC, 2002
	SM	Abstract of "Plasticizing Characteristics of High-Density Polyethylene" Wu et al., Suliao, 1988, 17 (4), 3 - 8
	SN	Abstract of "Effect of Technological Additives on Properties of Thermoplastic vulcanizates Based on Ethylene Propylene Rubber and Polyolefins" Kanauzov et al., Kauchuk i Rezina, 2000, (4), 12 - 15
	SO	Abstract of Polybutenes: a versatile modifier for plastics, J. D. Fotheringham, AddCon Asia (RAPRA), International Plastics Additives and Modifiers Conference, Singapore, October 28-29, 1997
	SP	Abstract of "Effect of Petroleum Plasticizers and Synthetic Oils on Rheological and service Properties of Polyolefins", M.D. Nasibova et al., Olefinov s Opyt. Z-dom, 1991 (14), 60-6
	SQ	"Rubber Chemicals and Additives", Rubber Technology Handbook, 1989, Werner Hoffman, Hanser Publishers, New York, pp. 294-305
	SR	"Plasticizers", Additives for Plastics, J. Stepek, H. Daoust, 1983, Springer Verlag, New York, pp. 6-69
	ST	"Lubricants and Other Processing Aids", Chemical Additives for the Plastics Industry, Properties, Applications, Toxicologies, Noyes Data Corporation, Park Ridge, NJ, 1987, pp. 107-116
NN	SU	"Synthetic Lubricants and High-Performance Functional Fluids: Chemistry, Technology, and Commercial Importance", "Polybutenes", Second Edition, Rudnick, Shubkin, eds., Marcel Dekker, Inc. New York, 1999, pp. 1-52, 357-392

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NN	AA	4,097,543	06/27/1978	Haag et al.			
	AB	4,693,838	09/15/1987	Varma et al.			
	AC	4,726,989	02/23/1988	Mrozinski			
	AD	4,824,718	04/25/1989	Hwang			
	AE	4,853,428	08/01/1989	Theodore et al.			
	AF	4,948,840	08/14/1990	Berta			
	AG	5,076,988	12/31/1991	Rifi			
	AH	5,079,287	01/07/1992	Takeshi et al.			
	AI	5,105,038	04/14/1992	Chen et al.			
	AJ	5,162,436	11/10/1992	Davis et al.			
	AK	5,180,865	01/19/1993	Heilman et al.			
	AL	5,240,966	08/31/1993	Iwasaki et al.			
	AM	5,340,848	08/23/1994	Asanuma et al.			
	AN	5,569,693	10/29/1996	Doshi et al.			
	AO	5,700,312	12/23/1997	Fausnight et al.			
	AP	5,776,589	07/07/1998	Mace et al.			
	AQ	6,191,078	02/20/2001	Shlomo et al.			
	AR	6,498,213	12/24/2002	Jeong et al.			
	AS	6,706,828	03/16/2004	DiMaio			
	AT	6,720,376	04/13/2004	Itoh et al.			
	AU	6,905,760	06/14/2005	Mukohara et al.			
	AV	2003/036577	02/20/2003	Hughes et al.			
	AW	2003/181575	09/25/2003	Schmidt et al.			
	AX	2004/054040	03/18/2004	Lin et al.			
NN	AY	2004/063806	04/01/2004	Kaamakari			

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		DOCUMENT NUMBER	PUBL. DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
NN	AZ	DE 1769723	02.10.72	Germany w/abstract				
	AAA	EP 0 210 733	04.02.87	Europe				
	AAB	EP 0 315 481	10.08.89	Europe				
	AAC	EP 0 343 943	29.11.89	Europe				
	AAD	EP 0 407 098	09.01.91	Europe				
	AAE	EP 0 431 475	12.06.91	Europe				
	AAF	EP 0 476 401	25.03.92	Europe				
NN	AAG	EP 0 476 700	25.03.92	Europe				

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		DOCUMENT NUMBER	PUBL. DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
NN	AA	EP 0 682 074	15.11.95	Europe				
	AB	EP 0 699 519	06.03.96	Europe				
	AC	EP 0 716 124	12.06.96	Europe				
	AD	EP 0 755 970	29.01.97	Europe				
	AE	EP 0 757 076	05.02.97	Europe				
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OTHER DISCLOSURES (Including Author, Title, Date, Pertinent Pages of Publication, Etc.)

NN	AAC	Khungar, S.L.; "Flexible Films of Polypropylene Plasticized with Polybutenes", Amoco Chemicals, pp. 2992-2996, 1996.
	AAD	Pratt, C. F. et al.; "Control of Phase Separation and Voiding in Oil-Filled Polypropylene", Journal of Applied Polymers Science, Vo. 18, pp. 3621-3631, 1974.
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EXAMINER

/Nathan Nutter/ (11/24/2006)

DATE CONSIDERED

***EXAMINER:** Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next comment to applicant